



Parameter	Rating	Units
Blocking Voltage	100	V _P
Load Current	2.5	A _{rms} / A _{DC}
On-Resistance (max)	0.34	Ω

Features

- \bullet Handle Load Currents Up to 2.5A $_{\rm DC}/{\rm A_{rms}}$
- 2500V_{rms} Input/Output Isolation
- Power SIP Package
- High Reliability
- No Moving Parts
- · Low Drive Power Requirements
- · Arc-Free With No Snubbing Circuits
- No EMI/RFI Generation
- Flammability Rating UL 94 V-0

Applications

- Industrial Controls
- Motor Control
- Robotics
- Medical Equipment—Patient/Equipment Isolation
- Instrumentation
- Multiplexers
- Data Acquisition
- Electronic Switching
- I/O Subsystems
- · Meters (Watt-Hour, Water, Gas)
- IC Equipment
- · Home Appliances

Description

IXYS Integrated Circuits brings OptoMOS® technology, reliability, and compact size to a new family of high-power, solid state relays. As part of that family, the CPC1916 is a single-pole, normally open (1-Form-A) solid state relay.

The CPC1916 employs optically coupled MOSFET technology to provide 2500V_{rms} of input to output isolation. The optically coupled outputs, that use patented OptoMOS architecture, are controlled by a highly efficient infrared LED. The combination of low on-resistance and high load-current handling capabilities makes the relay suitable for a variety of high-performance switching applications.

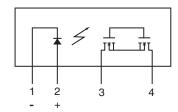
Approvals

• UL 508 Certified Component: File E69938

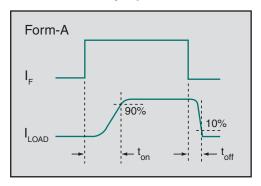
Ordering Information

Part #	Description
CPC1916Y	4-Pin (8-Pin Body) Power SIP Package (25 per tube)

Pin Configuration



Switching Characteristics of Normally Open Devices











Absolute Maximum Ratings @ 25°C

Parameter	Ratings	Units
Blocking Voltage	100	V _P
Reverse Input Voltage	5	V
Input control Current	50	mA
Peak (10ms)	1	Α
Input Power Dissipation 1	150	mW
Total Power Dissipation ²	2400	mW
Isolation Voltage, Input to Output	2500	V_{rms}
Operational Temperature	-40 to +85	°C
Storage Temperature	-40 to +125	°C

Absolute Maximum Ratings are stress ratings. Stresses in excess of these ratings can cause permanent damage to the device. Functional operation of the device at conditions beyond those indicated in the operational sections of this data sheet is not implied.

Typical values are characteristic of the device at +25°C, and are the result of engineering evaluations. They are provided for information purposes only, and are not part of the manufacturing testing requirements.

Electrical Characteristics @ 25°C

Parameter	Conditions	Symbol	Min	Тур	Max	Units
Output Characteristics					<u>'</u>	
Load Current, Continuous	Free air	IL	-	-	2.5	A_{rms}/A_{DC}
Peak Load Current	t <u><</u> 10ms	I _{LPK}	-	-	±6	A _P
On-Resistance ¹	I _L =1A	R _{ON}	-	-	0.34	Ω
Off-State Leakage Current	V _L =100V _P	I _{LEAK}	-	-	1	μΑ
Switching Speeds						
Turn-On	I 10m / \/ 10\/	t _{on}	-	-	5	ma
Turn-Off	I _F =10mA, V _L =10V	t _{off}	-	-	3	ms
Input Characteristics						
Input Control Current to Activate	I _L =1A	I _F	-	3.3	10	mA
Input Control Current to Deactivate	-	I _F	0.3	-	-	mA
Input Voltage Drop	I _F =10mA	V _F	0.9	1.35	1.56	V
Reverse Input Current	V _R =5V	I _R	-	-	10	μΑ
Common Characteristics			·		•	
Capacitance, Input/Output	V _{IO} =0V, f=1MHz	C _{IO}	-	2	-	pF

Measurement taken within 1 second of on-time.

Thermal Characteristics

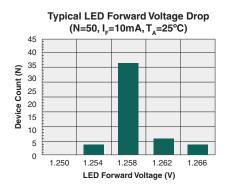
Parameter	Conditions	Symbol	Min	Тур	Max	Units
Thermal Impedance (junction to case)	-	R _{e.IC}	-	1.5	-	°C/W

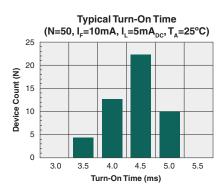
¹ Derate linearly 1.33 mW / °C

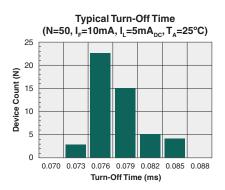
² Derate linearly 20 mW / °C

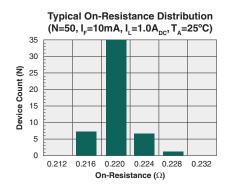


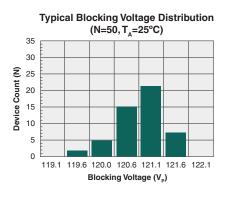
PERFORMANCE DATA*

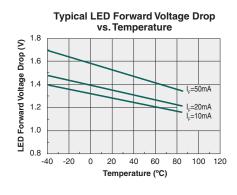


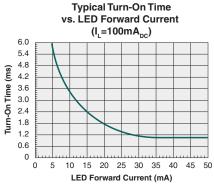


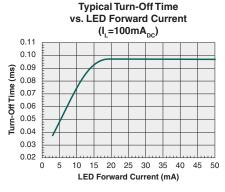


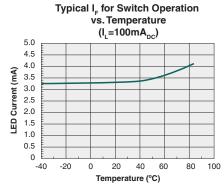


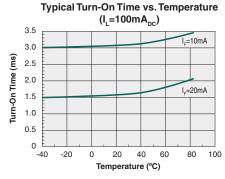


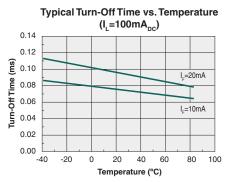








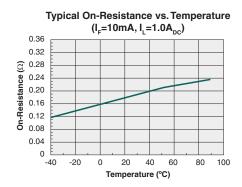


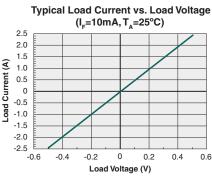


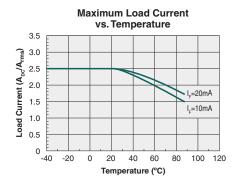
*Unless otherwise noted, data presented in these graphs is typical of device operation at 25°C. For guaranteed parameters not indicated in the written specifications, please contact our application department.

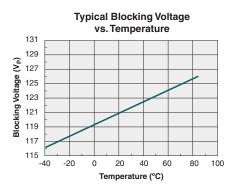


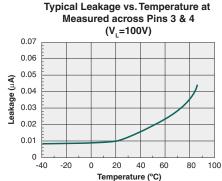
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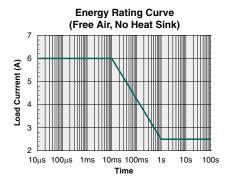














Manufacturing Information

Moisture Sensitivity

All plastic encapsulated semiconductor packages are susceptible to moisture ingression. IXYS Integrated Circuits classifies its plastic encapsulated devices for moisture sensitivity according to the latest version of the joint industry standard, IPC/JEDEC J-STD-020, in force at the time of product evaluation. We test all of our products to the maximum conditions set forth in the standard, and guarantee proper operation of our devices when handled according to the limitations and information in that standard as well as to any limitations set forth in the information or standards referenced below.

Failure to adhere to the warnings or limitations as established by the listed specifications could result in reduced product performance, reduction of operable life, and/or reduction of overall reliability.

This product carries a Moisture Sensitivity Level (MSL) classification as shown below, and should be handled according to the requirements of the latest version of the joint industry standard **IPC/JEDEC J-STD-033**.

Device	Moisture Sensitivity Level (MSL) Classification
CPC1916Y	MSL 1

ESD Sensitivity



This product is ESD Sensitive, and should be handled according to the industry standard JESD-625.

Soldering Profile

Provided in the table below is the Classification Temperature (T_C) of this product and the maximum dwell time the body temperature of this device may be (T_C - 5)°C or greater. The classification temperature sets the Maximum Body Temperature allowed for this device during lead-free reflow processes. For through-hole devices, and any other processes, the guidelines of **J-STD-020** must be observed.

Device	Classification Temperature (T _c)	Dwell Time (t _p)	Max Reflow Cycles
CPC1916Y	245°C	30 seconds	1

Board Wash

IXYS Integrated Circuits recommends the use of no-clean flux formulations. Board washing to reduce or remove flux residue following the solder reflow process is acceptable provided proper precautions are taken to prevent damage to the device. These precautions include, but are not limited to: using a low pressure wash and providing a follow up bake cycle sufficient to remove any moisture trapped within the device due to the washing process. Due to the variability of the wash parameters used to clean the board, determination of the bake temperature and duration necessary to remove the moisture trapped within the package is the responsibility of the user (assembler). Cleaning or drying methods that employ ultrasonic energy may damage the device and should not be used. Additionally, the device must not be exposed to flux or solvents that are Chlorine- or Fluorine-based.



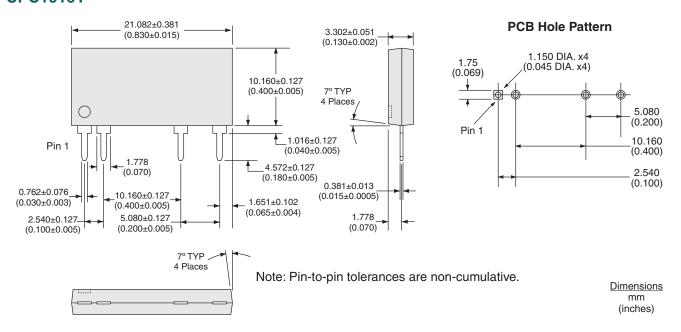






MECHANICAL DIMENSIONS

CPC1916Y



For additional information please visit our website at: www.ixysic.com

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